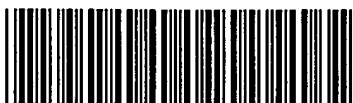


Search Notes

Application/Control No.

10/662,516

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

SZUM ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	128,141, 143,145	2/7/2006	JDL
522	178,904	2/7/2006	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	2/7/2006	JDL